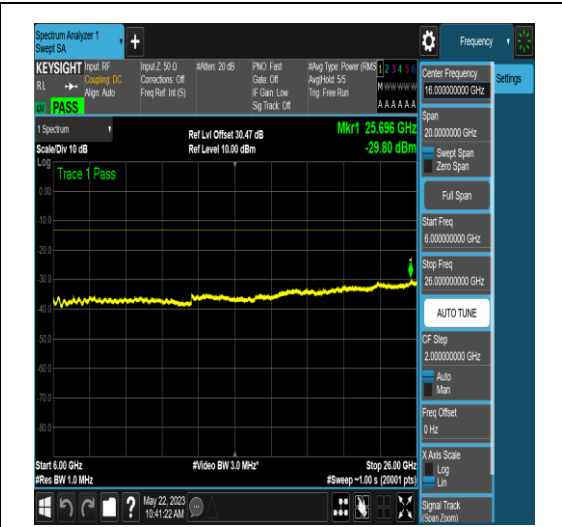
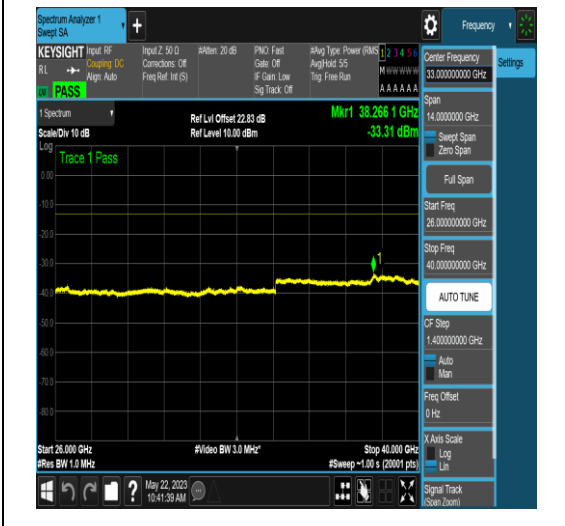


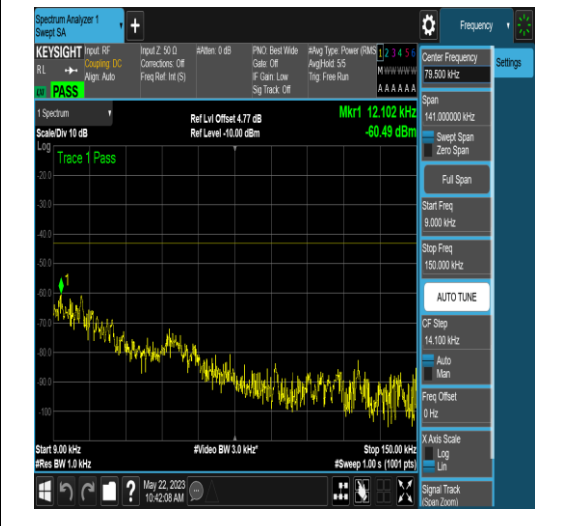
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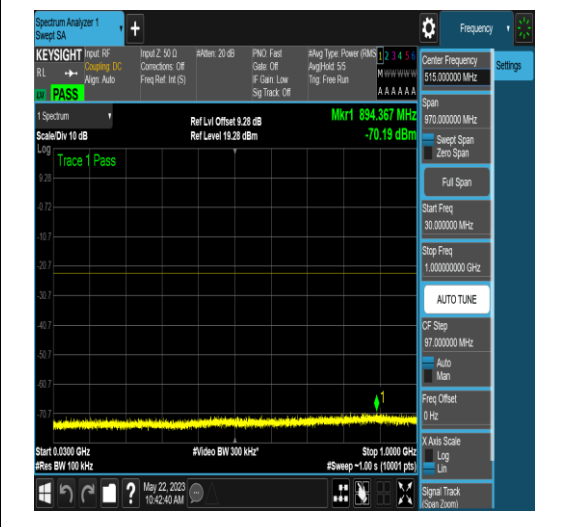
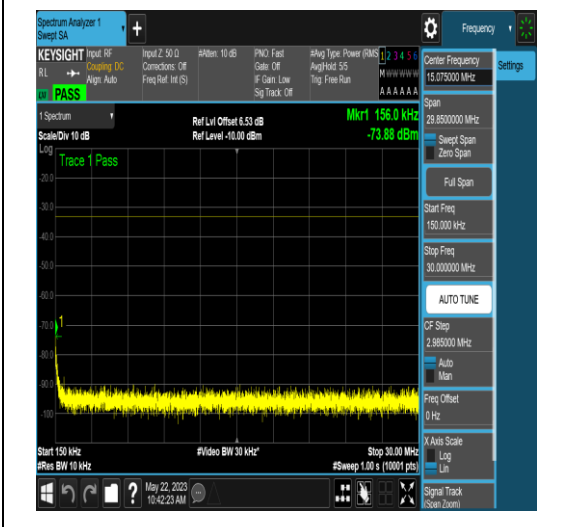
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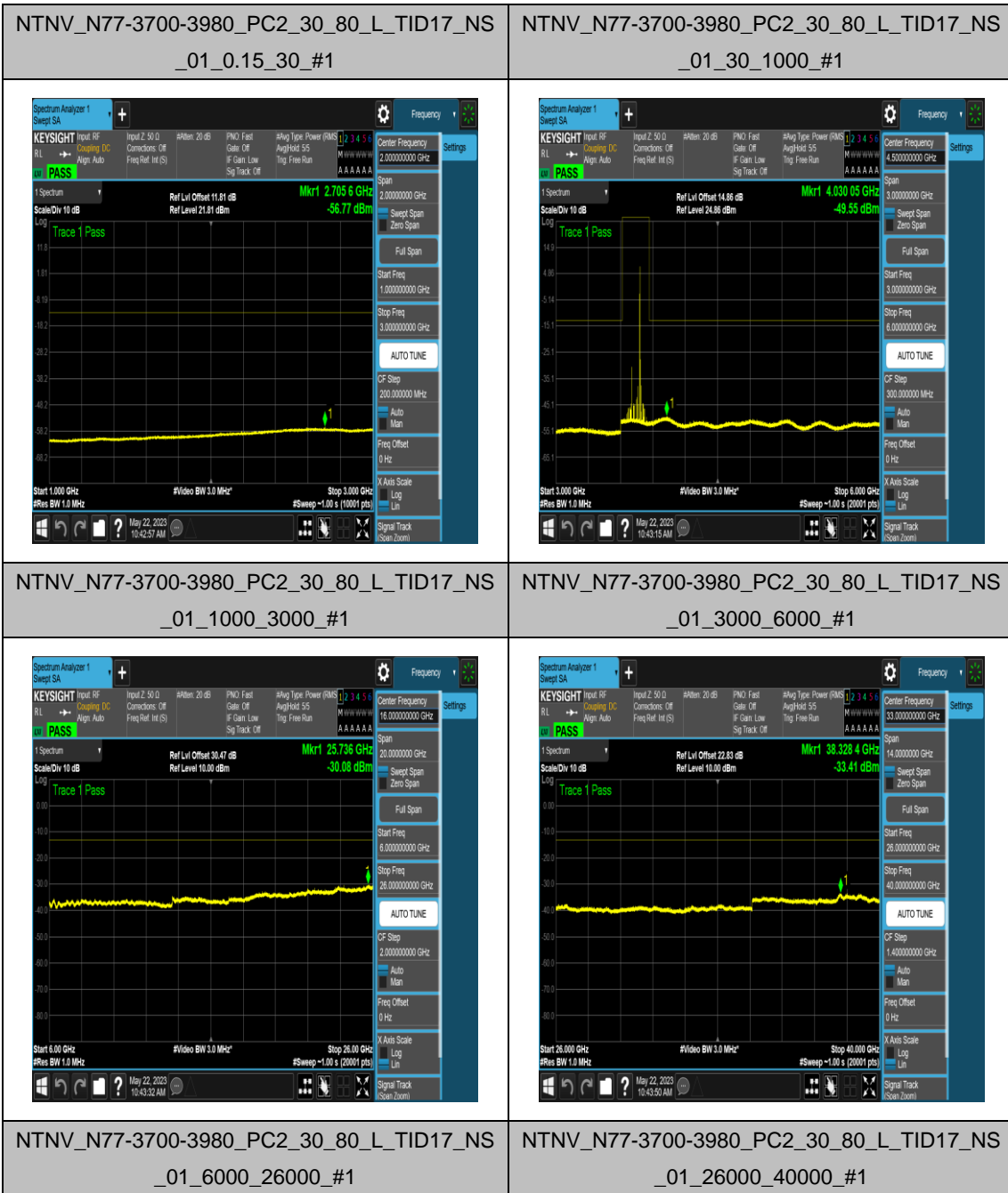


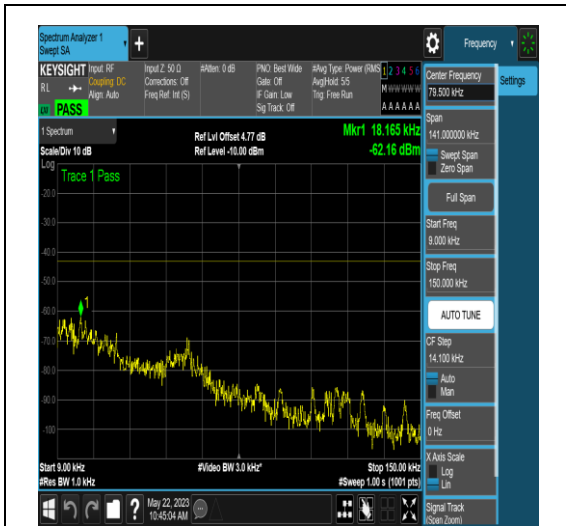
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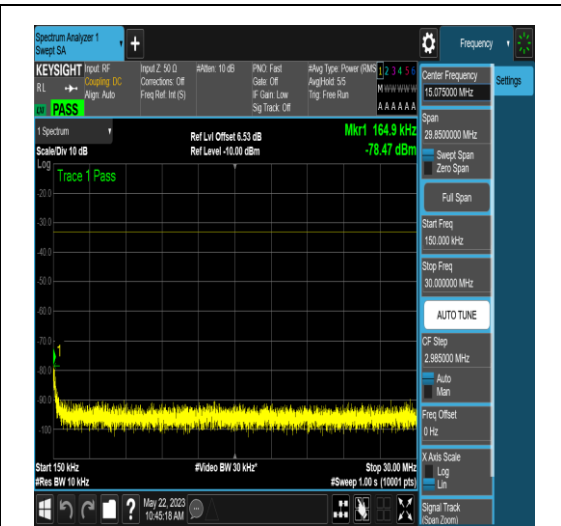
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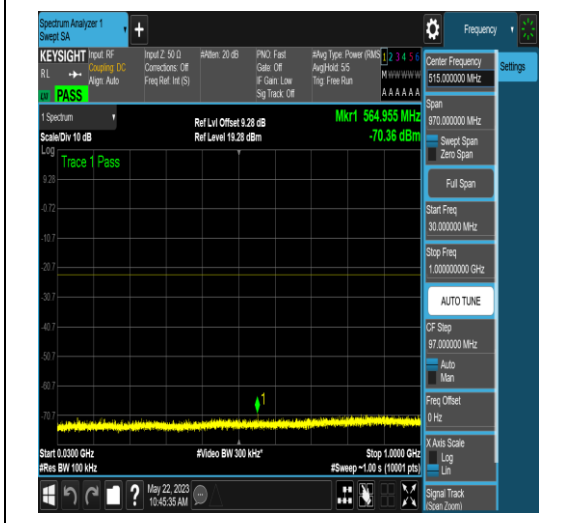




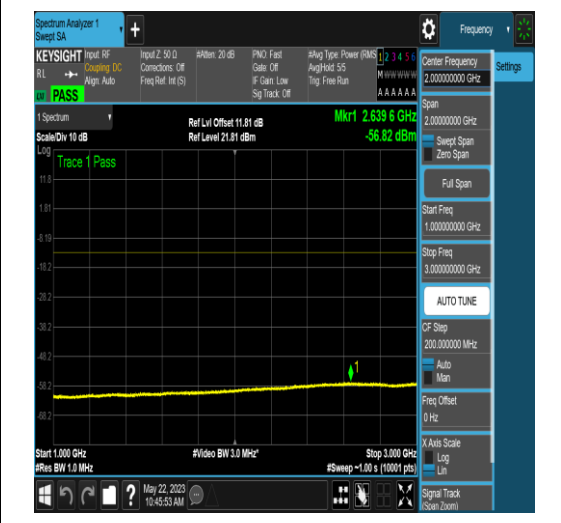
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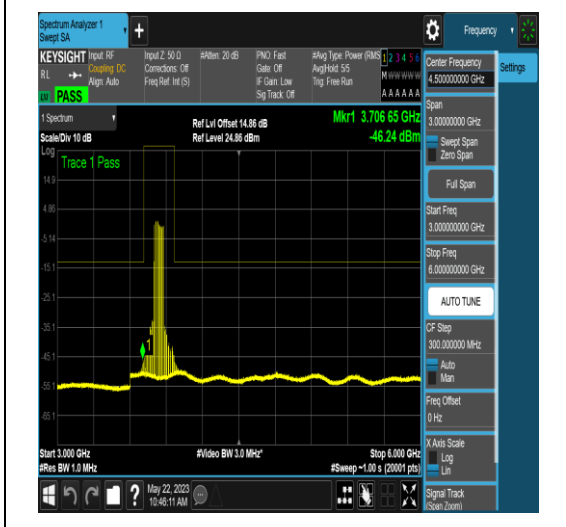
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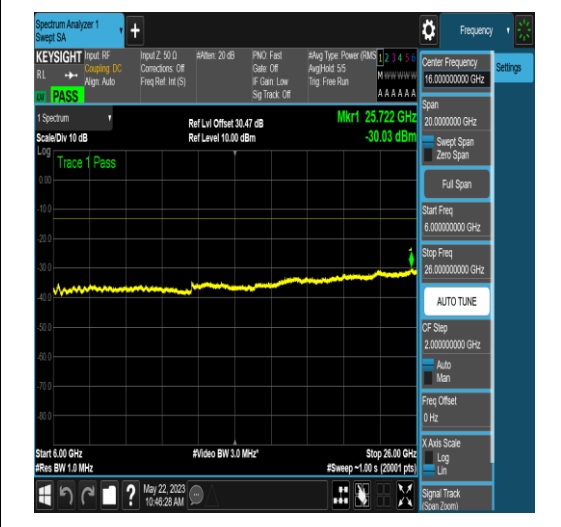
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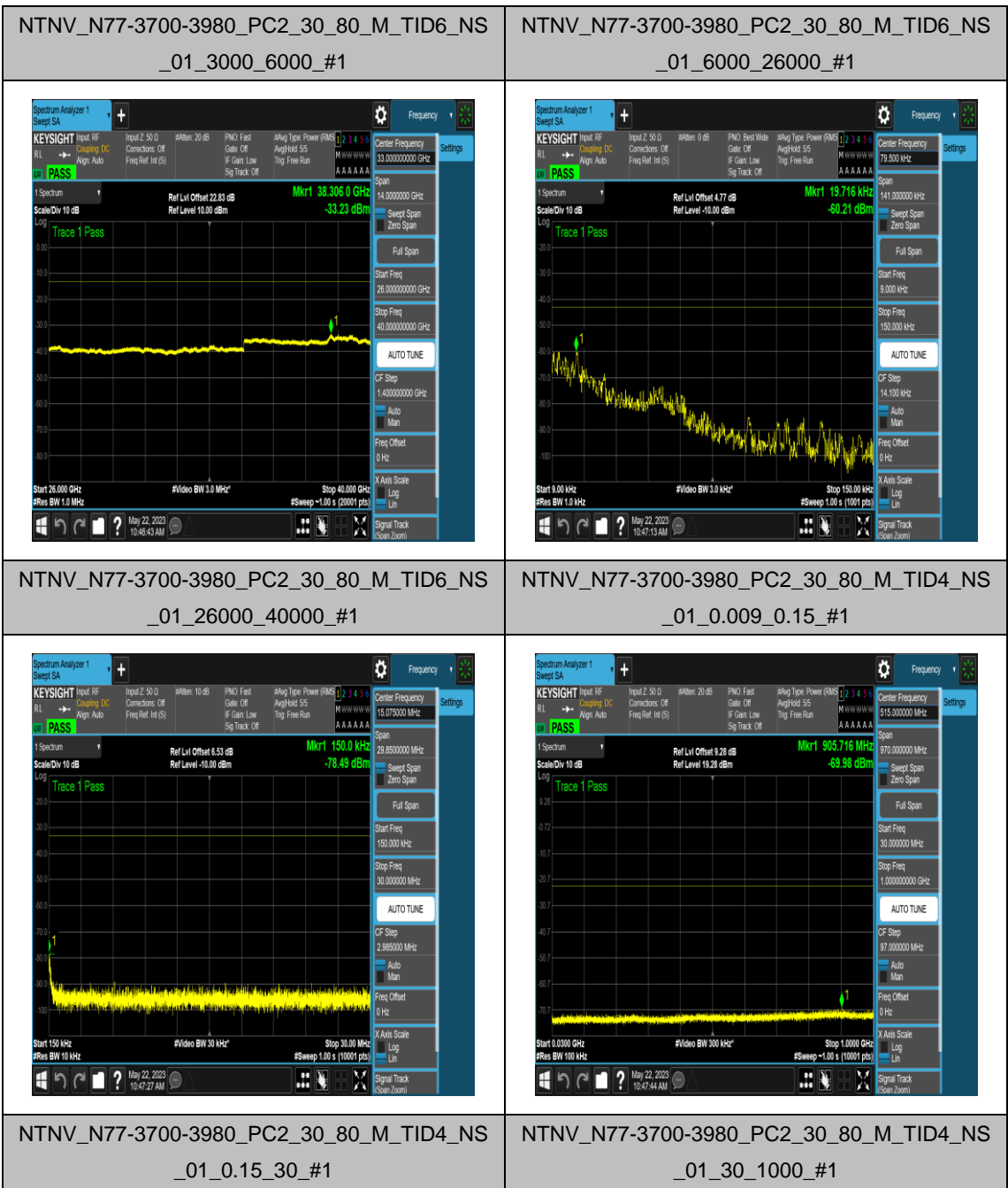


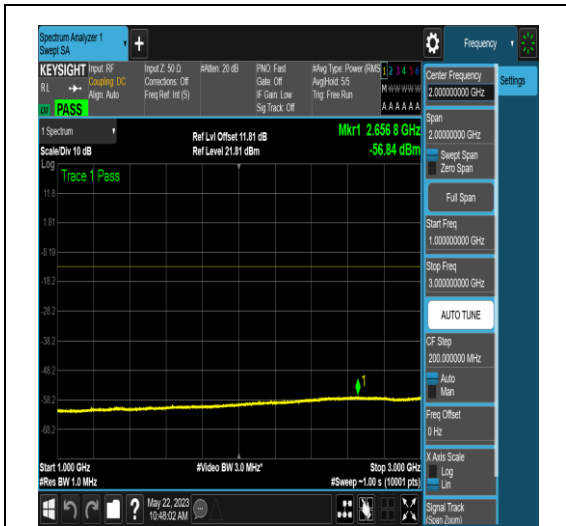
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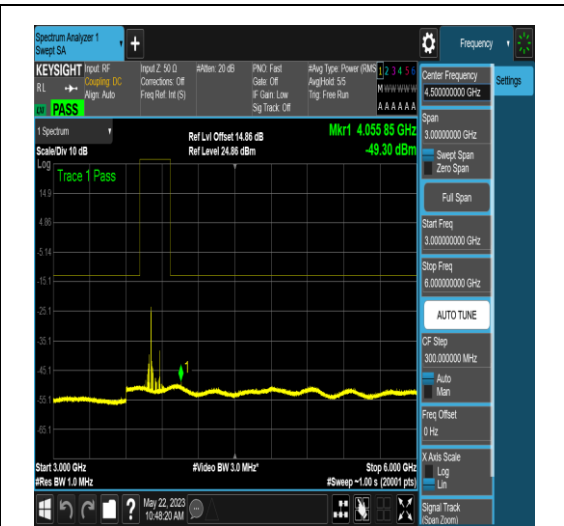
Waltek Testing Group (Shenzhen) Co., Ltd.
<http://www.waltek.com.cn>



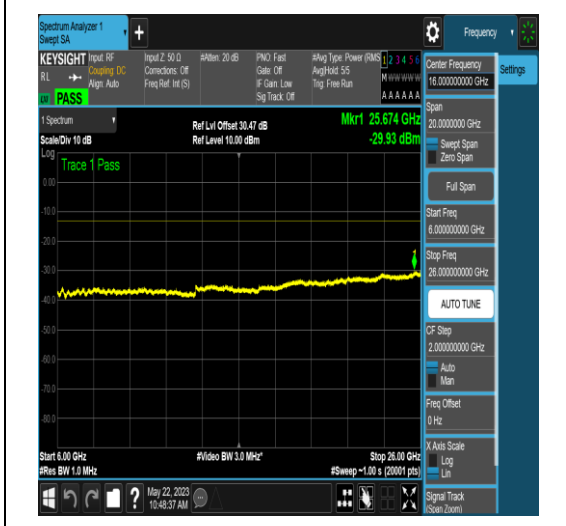




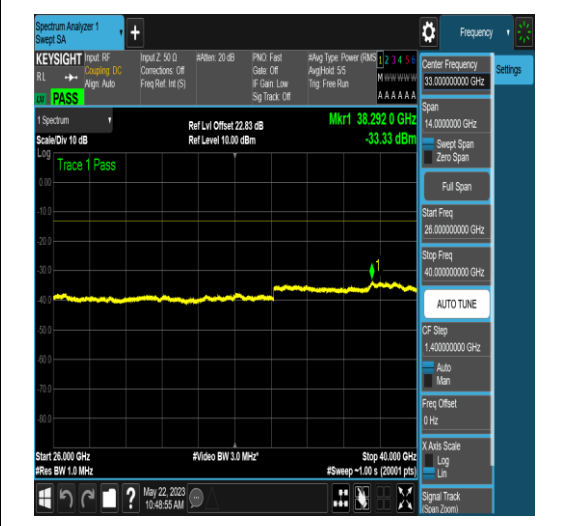
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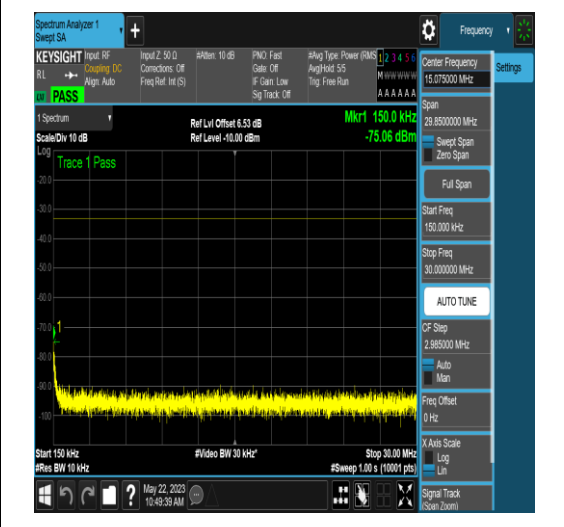
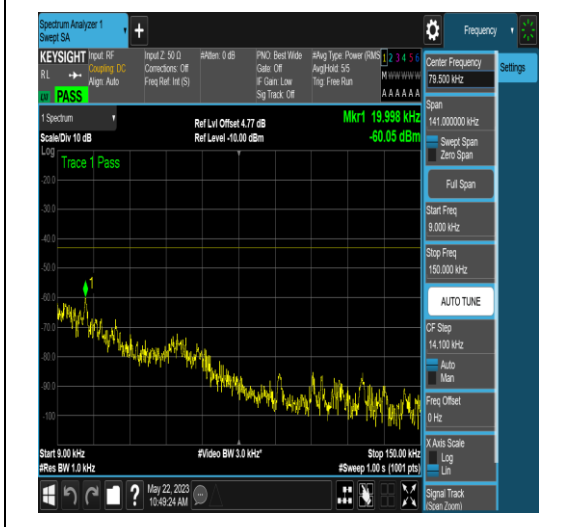
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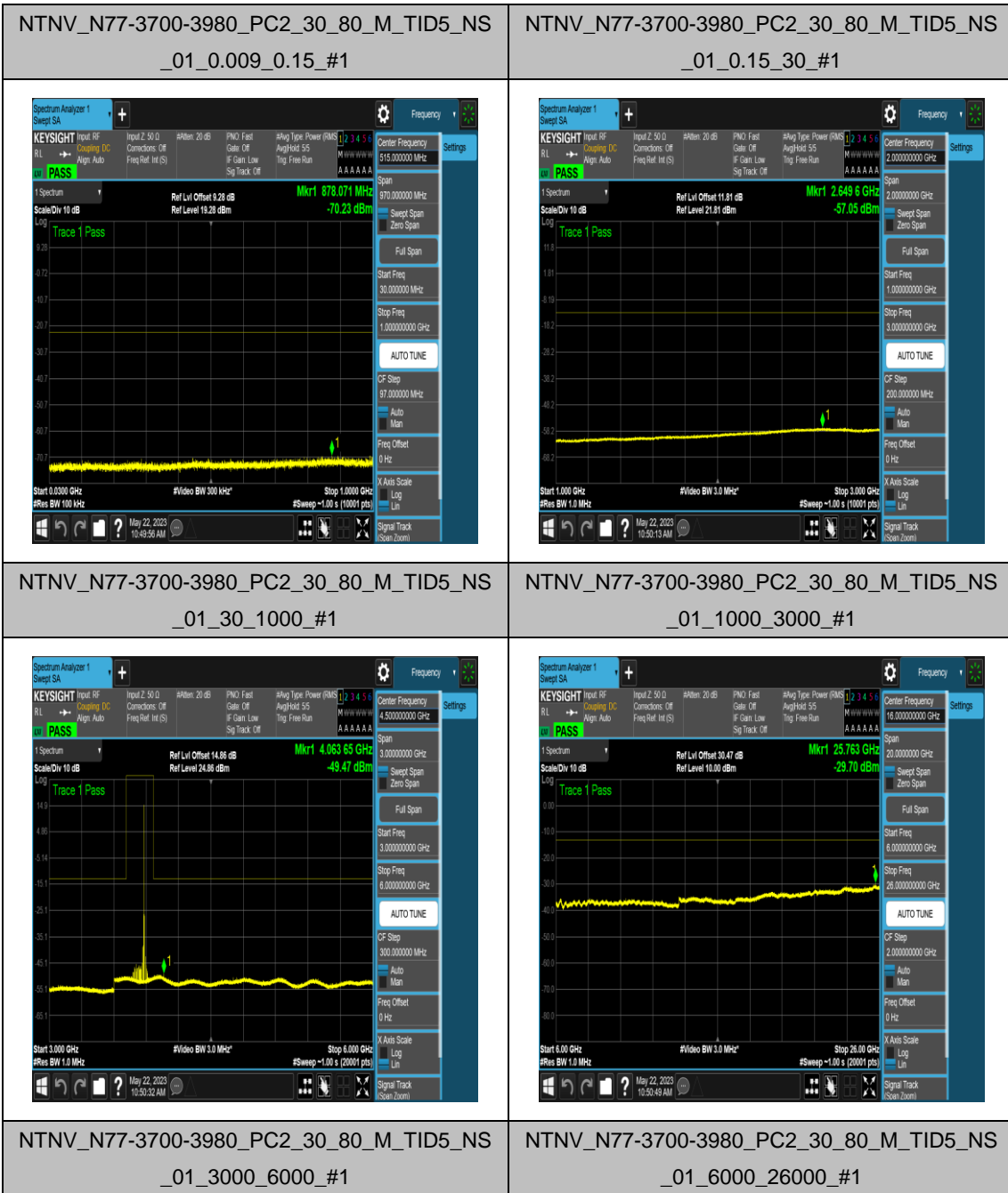


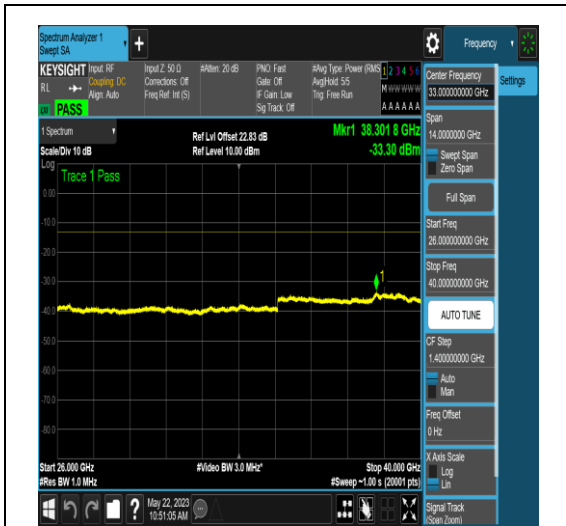
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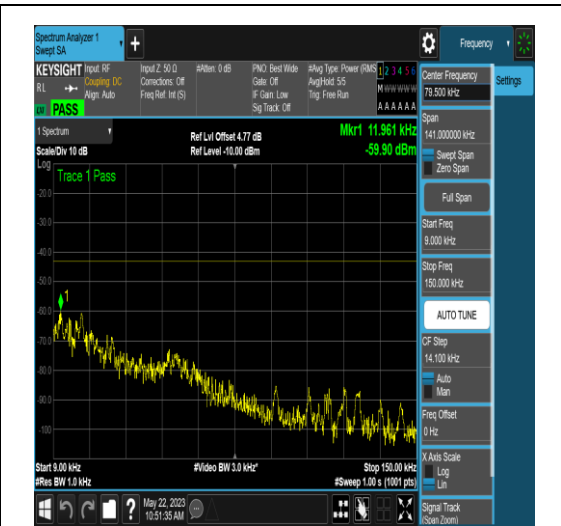
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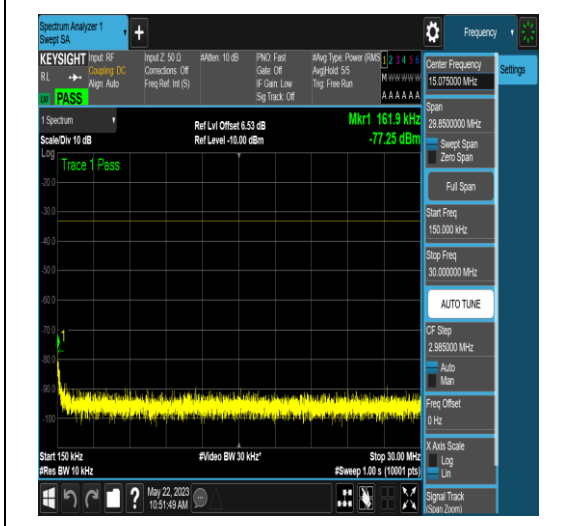




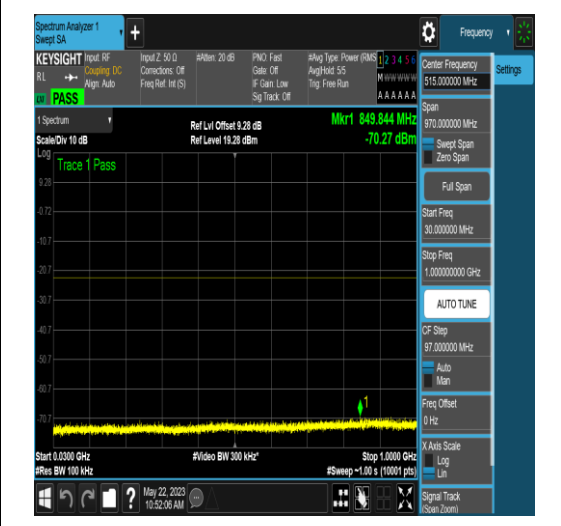
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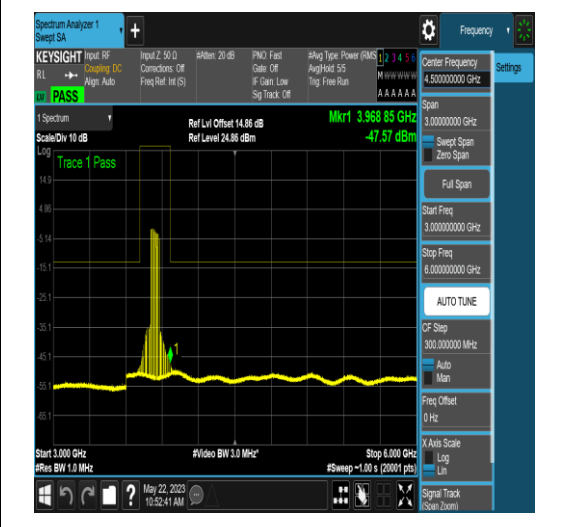
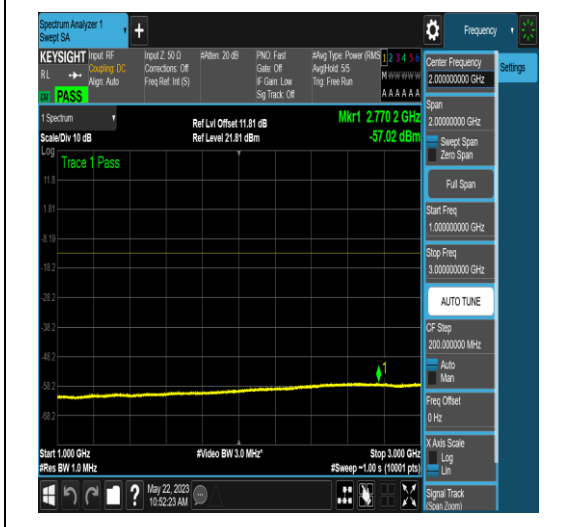
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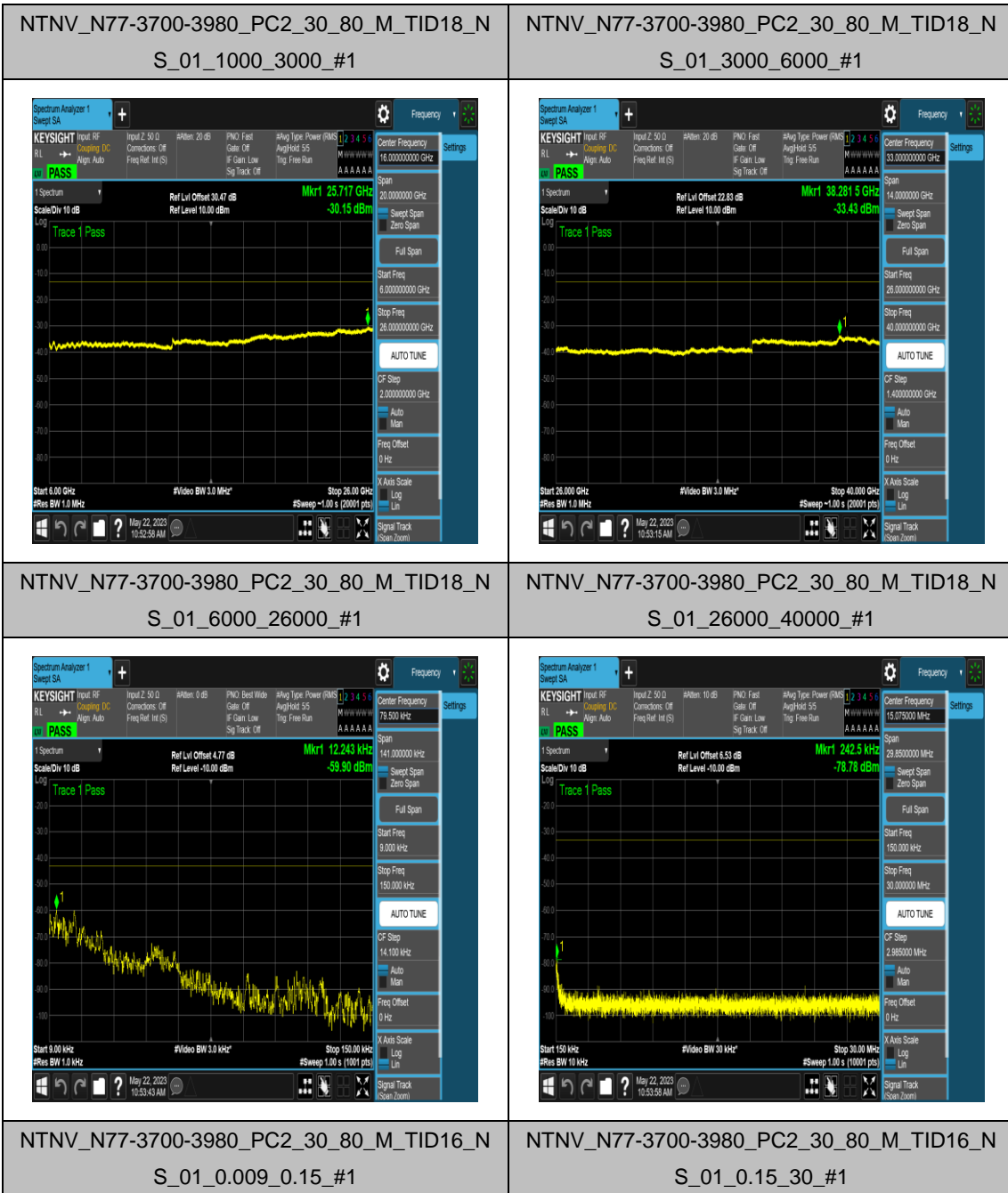


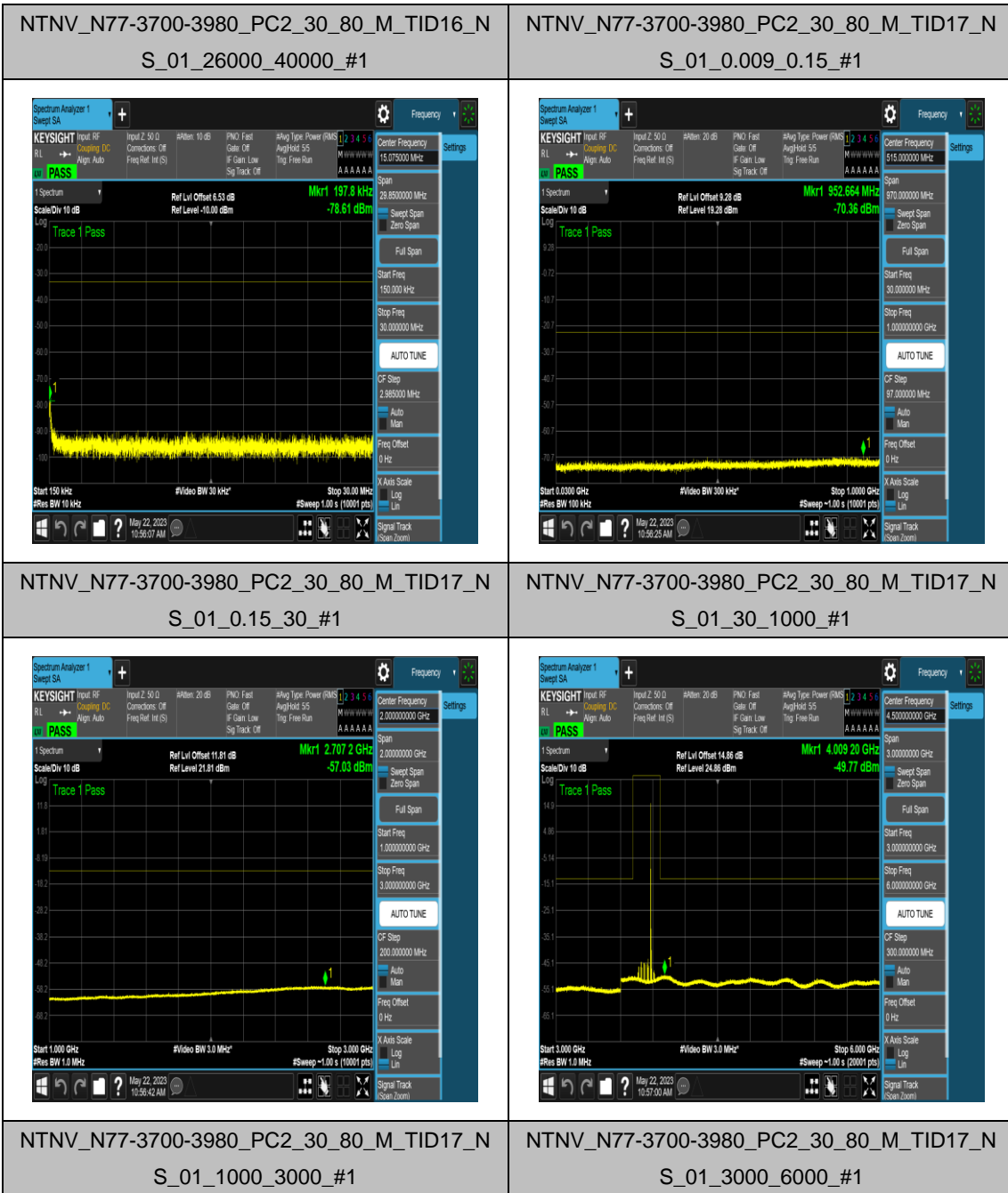
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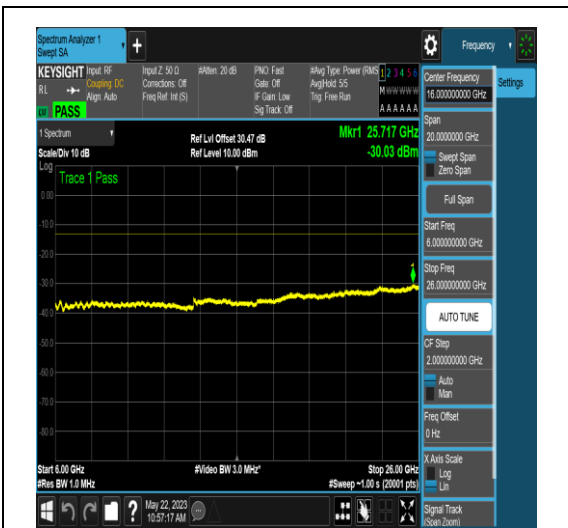


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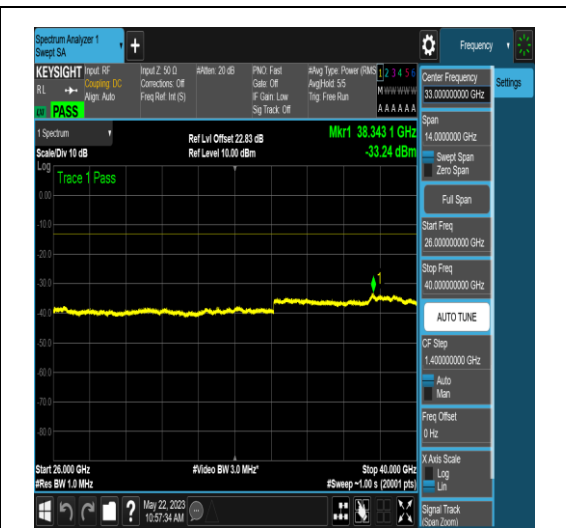




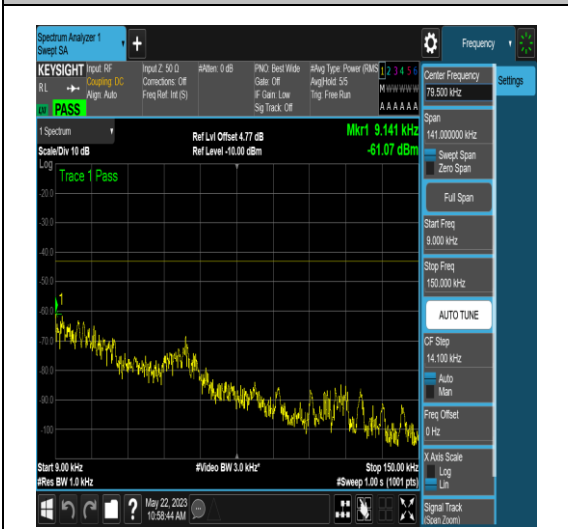




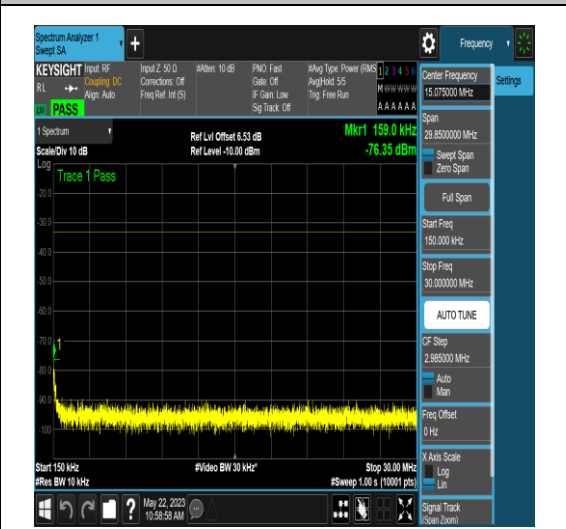
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